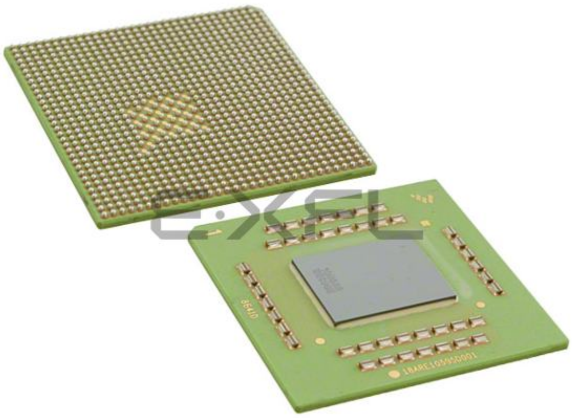

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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Obsolete
Core Processor	PowerPC e600
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.25GHz
Co-Processors/DSP	-
RAM Controllers	DDR, DDR2
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	994-BCBGA, FCCBGA
Supplier Device Package	994-FCCBGA (33x33)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc8641hx1250hc

2 Electrical Characteristics

This section provides the AC and DC electrical specifications and thermal characteristics for the MPC8641. The MPC8641 is currently targeted to these specifications.

2.1 Overall DC Electrical Characteristics

This section covers the ratings, conditions, and other characteristics.

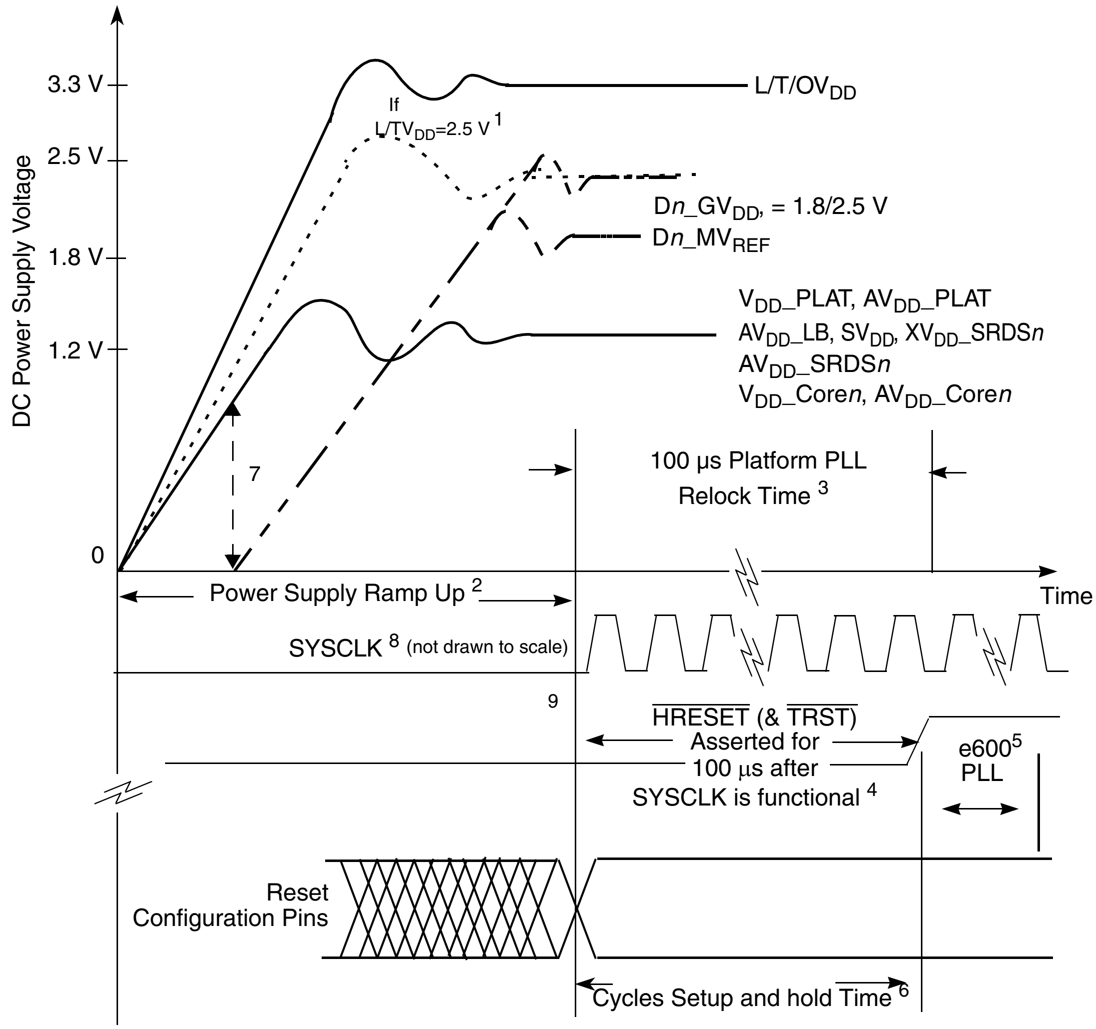
2.1.1 Absolute Maximum Ratings

Table 1 provides the absolute maximum ratings.

Table 1. Absolute Maximum Ratings[1]

Characteristic	Symbol	Absolute Maximum Value	Unit	Notes
Cores supply voltages	V_{DD}_Core0, V_{DD}_Core1	–0.3 to 1.21 V	V	2
Cores PLL supply	AV_{DD}_Core0, AV_{DD}_Core1	–0.3 to 1.21 V	V	—
SerDes Transceiver Supply (Ports 1 and 2)	SV_{DD}	–0.3 to 1.21 V	V	—
SerDes Serial I/O Supply Port 1	XV_{DD}_SRDS1	–0.3 to 1.21V	V	—
SerDes Serial I/O Supply Port 2	XV_{DD}_SRDS2	–0.3 to 1.21 V	V	—
SerDes DLL and PLL supply voltage for Port 1 and Port 2	AV_{DD}_SRDS1, AV_{DD}_SRDS2	–0.3 to 1.21V	V	—
Platform Supply voltage	V_{DD}_PLAT	–0.3 to 1.21V	V	—
Local Bus and Platform PLL supply voltage	AV_{DD}_LB, AV_{DD}_PLAT	–0.3 to 1.21V	V	—
DDR and DDR2 SDRAM I/O supply voltages	D1_GV_{DD}, D2_GV_{DD}	–0.3 to 2.75 V	V	3
		–0.3 to 1.98 V	V	3
eTSEC 1 and 2 I/O supply voltage	LV_{DD}	–0.3 to 3.63 V	V	4
		–0.3 to 2.75 V	V	4
eTSEC 3 and 4 I/O supply voltage	TV_{DD}	–0.3 to 3.63 V	V	4
		–0.3 to 2.75 V	V	4
Local Bus, DUART, DMA, Multiprocessor Interrupts, System Control & Clocking, Debug, Test, Power management, I^2C, JTAG and Miscellaneous I/O voltage	OV_{DD}	–0.3 to 3.63 V	V	—

Figure 3 illustrates the Power Up sequence as described above.



Notes:

1. Dotted waveforms correspond to optional supply values for a specified power supply. See Table 2.
2. The recommended maximum ramp up time for power supplies is 20 milliseconds.
3. Refer to Section 5, "RESET Initialization" for additional information on PLL relock and reset signal assertion timing requirements.
4. Refer to Table 11 for additional information on reset configuration pin setup timing requirements. In addition see Figure 68 regarding $\overline{\text{HRESET}}$ and JTAG connection details including $\overline{\text{TRST}}$.
5. e600 PLL relock time is 100 microseconds maximum plus 255 MPX_clk cycles.
6. Stable PLL configuration signals are required as stable SYSCLK is applied. All other POR configuration inputs are required 4 SYSCLK cycles before $\overline{\text{HRESET}}$ negation and are valid at least 2 SYSCLK cycles after $\overline{\text{HRESET}}$ has negated (hold requirement). See Section 5, "RESET Initialization" for more information on setup and hold time of reset configuration signals.
7. V_{DD}_PLAT, AV_{DD}_PLAT must strictly reach 90% of their recommended voltage before the rail for D*n*_GV_{DD}, and D*n*_MV_{REF} reaches 10% of their recommended voltage.
8. SYSCLK must be driven only AFTER the power for the various power supplies is stable.
9. In device sleep mode, the reset configuration signals for DRAM types (TSEC2_TXD[4],TSEC2_TX_ER) must be valid BEFORE $\overline{\text{HRESET}}$ is asserted.

Figure 3. MPC8641 Power-Up and Reset Sequence

Table 24. GMII, MII, RMII, TBI and FIFO DC Electrical Characteristics (continued)

Parameter	Symbol	Min	Max	Unit	Notes
Input low current (V_{IN} = GND)	I_{IL}	–600	—	μA	3

Notes:

1 LV_{DD} supports eTSECs 1 and 2.
2 TV_{DD} supports eTSECs 3 and 4.
3 The symbol V_{IN}, in this case, represents the LV_{IN} and TV_{IN} symbols referenced in Table 1 and Table 2.

Table 25. GMII, RGMII, RTBI, TBI and FIFO DC Electrical Characteristics

Parameters	Symbol	Min	Max	Unit	Notes
Supply voltage 2.5 V	LV_{DD}/TV_{DD}	2.375	2.625	V	1,2
Output high voltage (LV_{DD}/TV_{DD} = Min, I_{OH} = –1.0 mA)	V_{OH}	2.00	—	V	—
Output low voltage (LV_{DD}/TV_{DD} = Min, I_{OL} = 1.0 mA)	V_{OL}	—	0.40	V	—
Input high voltage	V_{IH}	1.70	—	V	—
Input low voltage	V_{IL}	—	0.90	V	—
Input high current ($V_{IN} = LV_{DD}$, $V_{IN} = TV_{DD}$)	I_{IH}	—	10	μA	1, 2,3
Input low current (V_{IN} = GND)	I_{IL}	–15	—	μA	3

Note:

1 LV_{DD} supports eTSECs 1 and 2.
2 TV_{DD} supports eTSECs 3 and 4.
3 Note that the symbol V_{IN}, in this case, represents the LV_{IN} and TV_{IN} symbols referenced in Table 1 and Table 2.

8.2 FIFO, GMII, MII, TBI, RGMII, RMII, and RTBI AC Timing Specifications

The AC timing specifications for FIFO, GMII, MII, TBI, RGMII, RMII and RTBI are presented in this section.

8.2.1 FIFO AC Specifications

The basis for the AC specifications for the eTSEC's FIFO modes is the double data rate RGMII and RTBI specifications, since they have similar performance and are described in a source-synchronous fashion like FIFO modes. However, the FIFO interface provides deliberate skew between the transmitted data and source clock in GMII fashion.

When the eTSEC is configured for FIFO modes, all clocks are supplied from external sources to the relevant eTSEC interface. That is, the transmit clock must be applied to the eTSEC*n*'s TSEC*n*_TX_CLK, while the receive clock must be applied to pin TSEC*n*_RX_CLK. The eTSEC internally uses the transmit

Table 29. GMII Receive AC Timing Specifications (continued)

At recommended operating conditions with L/TV_{DD} of 3.3 V ± 5% and 2.5 V ± 5%.

Parameter/Condition	Symbol [1]	Min	Typ	Max	Unit
RX_CLK clock fall time (80%-20%)	t_{GRXF}[2]	—	—	1.0	ns

Note:

1. The symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state) (reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{GRDVKH} symbolizes GMII receive timing (GR) with respect to the time data input signals (D) reaching the valid state (V) relative to the t_{RX} clock reference (K) going to the high state (H) or setup time. Also, t_{GRDXKL} symbolizes GMII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t_{GRX} clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{GRX} represents the GMII (G) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
2. Guaranteed by design.
3. ±100 ppm tolerance on RX_CLK frequency

Figure 11 provides the AC test load for eTSEC.

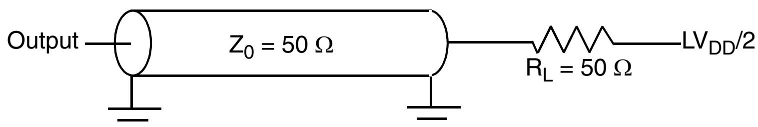


Figure 11. eTSEC AC Test Load

Figure 12 shows the GMII receive AC timing diagram.

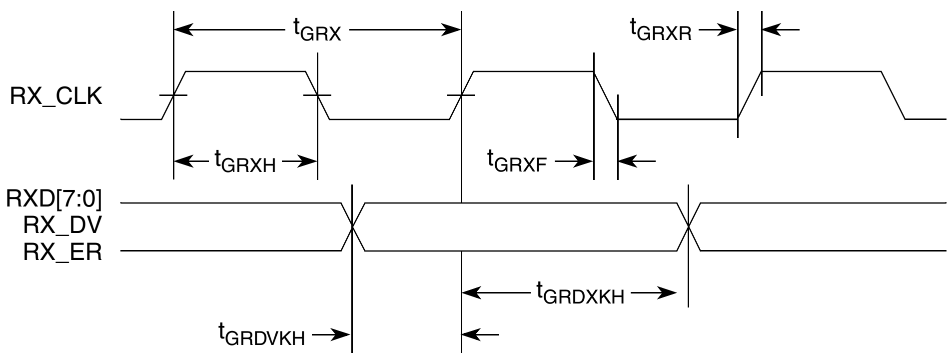


Figure 12. GMII Receive AC Timing Diagram

8.2.3 MII AC Timing Specifications

This section describes the MII transmit and receive AC timing specifications.

8.2.3.1 MII Transmit AC Timing Specifications

Table 30 provides the MII transmit AC timing specifications.

Table 30. MII Transmit AC Timing Specifications

At recommended operating conditions with L/TV_{DD} of 3.3 V ± 5%.

Parameter/Condition	Symbol [1]	Min	Typ	Max	Unit
TX_CLK clock period 10 Mbps	t_{MTX} [2]	—	400	—	ns
TX_CLK clock period 100 Mbps	t_{MTX}	—	40	—	ns
TX_CLK duty cycle	t_{MTXH}/t_{MTX}	35	—	65	%
TX_CLK to MII data TXD[3:0], TX_ER, TX_EN delay	t_{MTKHDX}	1	5	15	ns
TX_CLK data clock rise time (20%-80%)	t_{MTXR} [2]	1.0	—	4.0	ns
TX_CLK data clock fall time (80%-20%)	t_{MTXF} [2]	1.0	—	4.0	ns

Note:

1. The symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state) (reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{MTKHDX} symbolizes MII transmit timing (MT) for the time t_{MTX} clock reference (K) going high (H) until data outputs (D) are invalid (X). Note that, in general, the clock reference symbol representation is based on two to three letters representing the clock of a particular functional. For example, the subscript of t_{MTX} represents the MII(M) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
2. Guaranteed by design.

Figure 13 shows the MII transmit AC timing diagram.

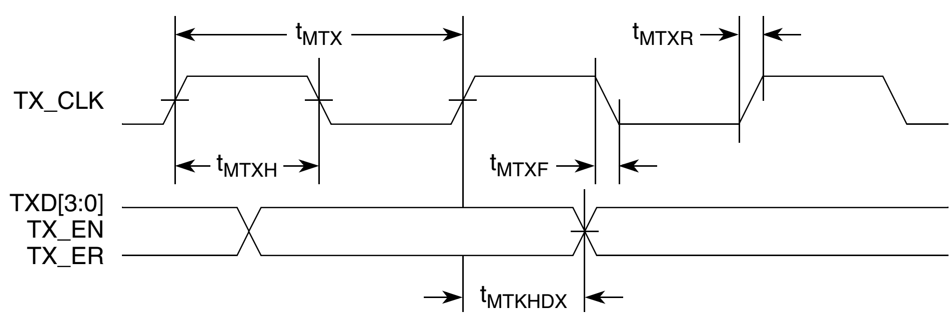


Figure 13. MII Transmit AC Timing Diagram

8.2.4 TBI AC Timing Specifications

This section describes the TBI transmit and receive AC timing specifications.

8.2.4.1 TBI Transmit AC Timing Specifications

Table 32 provides the TBI transmit AC timing specifications.

Table 32. TBI Transmit AC Timing Specifications

At recommended operating conditions with L/TV_{DD} of 3.3 V ± 5% and 2.5 V ± 5%.

Parameter/Condition	Symbol [1]	Min	Typ	Max	Unit
TCG[9:0] setup time GTX_CLK going high	t_{TTKHDV}	2.0	—	—	ns
TCG[9:0] hold time from GTX_CLK going high	t_{TTKHDX}	1.0	—	—	ns
GTX_CLK rise time (20%–80%)	t_{TTXR}[2]	—	—	1.0	ns
GTX_CLK fall time (80%–20%)	t_{TTXF}[2]	—	—	1.0	ns

Notes:

1. The symbols used for timing specifications herein follow the pattern of $t_{(\text{first two letters of functional block})(\text{signal})(\text{state })(\text{reference})(\text{state})}$ for inputs and $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$ for outputs. For example, t_{TTKHDV} symbolizes the TBI transmit timing (TT) with respect to the time from t_{TTX} (K) going high (H) until the referenced data signals (D) reach the valid state (V) or setup time. Also, t_{TTKHDX} symbolizes the TBI transmit timing (TT) with respect to the time from t_{TTX} (K) going high (H) until the referenced data signals (D) reach the invalid state (X) or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{TTX} represents the TBI (T) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
2. Guaranteed by design.

Figure 16 shows the TBI transmit AC timing diagram.

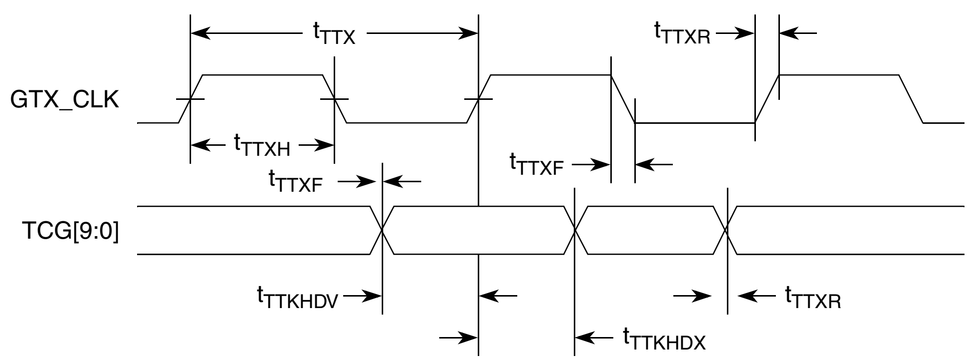


Figure 16. TBI Transmit AC Timing Diagram

Figure 26 to Figure 31 show the local bus signals.

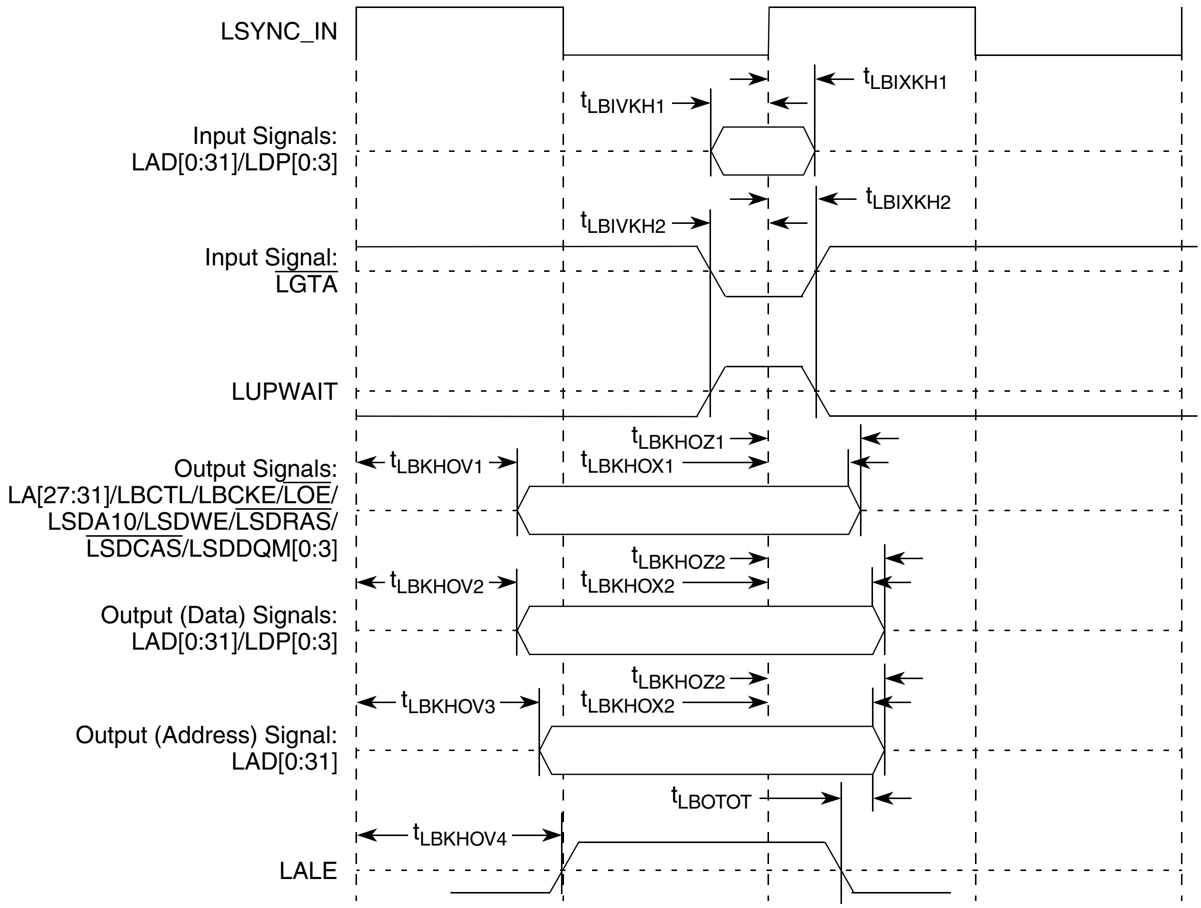


Figure 26. Local Bus Signals (PLL Enabled)

NOTE

PLL bypass mode is recommended when LBIU frequency is at or below 83 MHz. When LBIU operates above 83 MHz, LBIU PLL is recommended to be enabled.

Table 42 describes the general timing parameters of the local bus interface at OV_{DD} = 3.3 V with PLL bypassed.

Table 42. Local Bus Timing Parameters—PLL Bypassed

Parameter	Symbol [1]	Min	Max	Unit	Notes
Local bus cycle time	t_{LBK}	12	—	ns	2
Local bus duty cycle	t_{LBKH}/t_{LBK}	45	55	%	—
Internal launch/capture clock to LCLK delay	t_{LBKHKT}	2.3	3.9	ns	8
Input setup to local bus clock (except LGTA/LUPWAIT)	$t_{LBIVKH1}$	5.7	—	ns	4, 5
LGTA/LUPWAIT input setup to local bus clock	$t_{LBIVKL2}$	5.6	—	ns	4, 5
Input hold from local bus clock (except LGTA/LUPWAIT)	$t_{LBIXKH1}$	–1.8	—	ns	4, 5

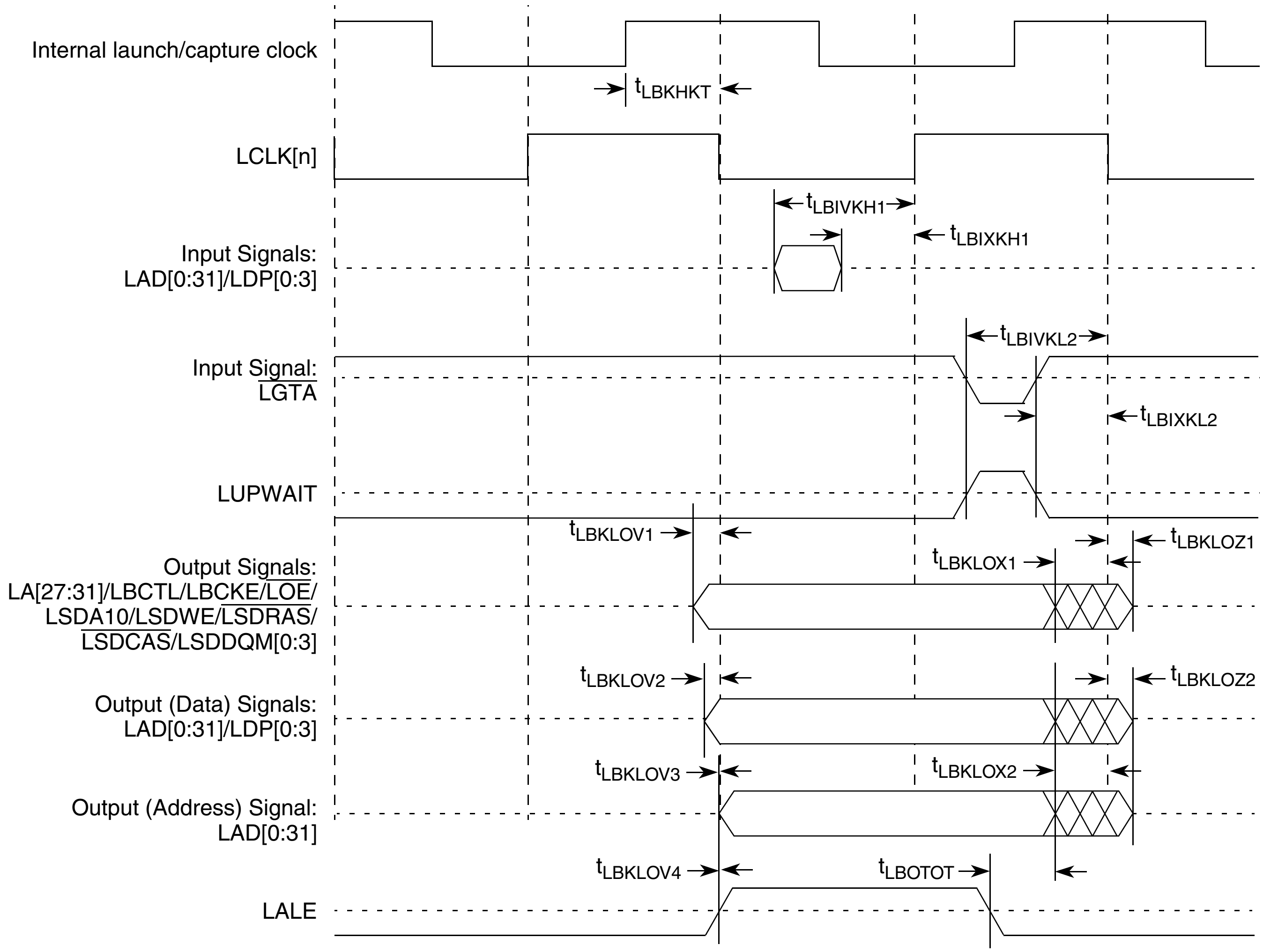


Figure 27. Local Bus Signals (PLL Bypass Mode)

NOTE

In PLL bypass mode, LCLK[n] is the inverted version of the internal clock with the delay of t_{LBKHKT}. In this mode, signals are launched at the rising edge of the internal clock and are captured at falling edge of the internal clock, with the exception of the LGTA/LUPWAIT signal, which is captured at the rising edge of the internal clock.

Table 45. I^2C DC Electrical Characteristics (continued)

At recommended operating conditions with OV_{DD} of 3.3 V ± 5%.

Parameter	Symbol	Min	Max	Unit	Notes
Capacitance for each I/O pin	C_I	—	10	pF	—

Notes:

1. Output voltage (open drain or open collector) condition = 3 mA sink current.
2. Refer to the *MPC8641 Integrated Host Processor Reference Manual* for information on the digital filter used.
3. I/O pins will obstruct the SDA and SCL lines if OV_{DD} is switched off.

12.2 I^2C AC Electrical Specifications

Table 46 provides the AC timing parameters for the I^2C interfaces.

Table 46. I^2C AC Electrical Specifications

All values refer to V_{IH} (min) and V_{IL} (max) levels (see Table 45).

Parameter	Symbol [1]	Min	Max	Unit
SCL clock frequency	f_{I2C}	0	400	kHz
Low period of the SCL clock	t_{I2CL} [4]	1.3	—	μs
High period of the SCL clock	t_{I2CH} [4]	0.6	—	μs
Setup time for a repeated START condition	t_{I2SVKH} [4]	0.6	—	μs
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t_{I2SXKL} [4]	0.6	—	μs
Data setup time	t_{I2DVKH} [4]	100	—	ns
Data input hold time: CBUS compatible masters I^2C bus devices	t_{I2DXKL}	 — 0 [2]	 — —	μs
Rise time of both SDA and SCL signals	t_{I2CR}	$20 + 0.1\ C_B$ [5]	300	ns
Fall time of both SDA and SCL signals	t_{I2CF}	$20 + 0.1\ C_b$ [5]	300	ns
Data output delay time	t_{I2OVKL}	—	0.9 [3]	μs
Set-up time for STOP condition	t_{I2PVKH}	0.6	—	μs
Bus free time between a STOP and START condition	t_{I2KHDX}	1.3	—	μs
Noise margin at the LOW level for each connected device (including hysteresis)	V_{NL}	$0.1 \times OV_{DD}$	—	V

— The SD*n*_REF_CLK input average voltage must be between 200 and 400 mV. Figure 42 shows the SerDes reference clock input requirement for single-ended signaling mode.

— To meet the input amplitude requirement, the reference clock inputs might need to be DC or AC-coupled externally. For the best noise performance, the reference of the clock could be DC or AC-coupled into the unused phase ($\overline{\mathrm{SD}n\_\mathrm{REF\_CLK}}$) through the same source impedance as the clock input (SD*n*_REF_CLK) in use.

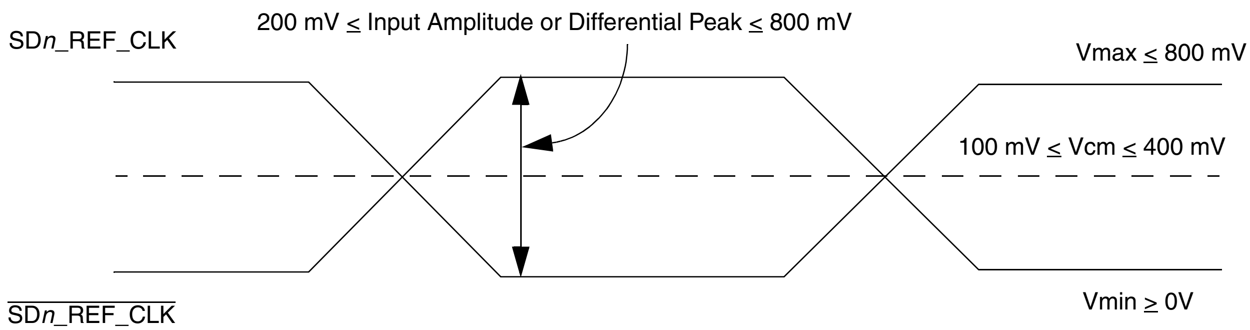


Figure 40. Differential Reference Clock Input DC Requirements (External DC-Coupled)

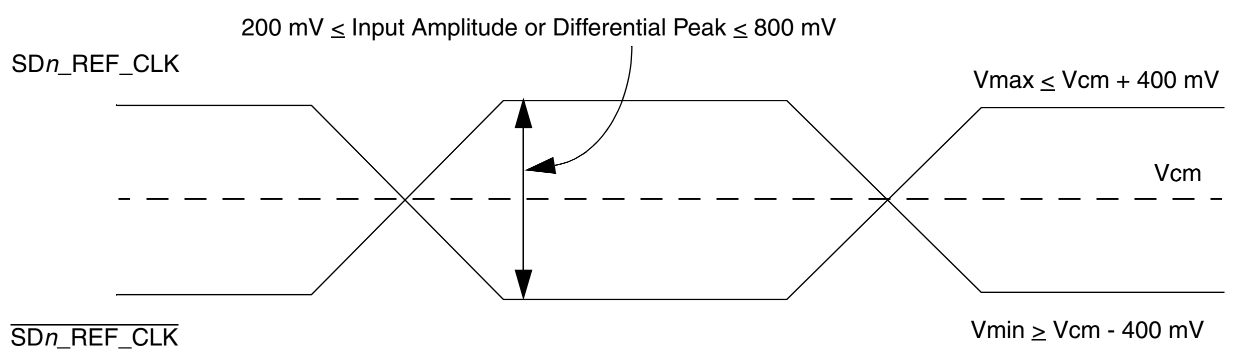


Figure 41. Differential Reference Clock Input DC Requirements (External AC-Coupled)

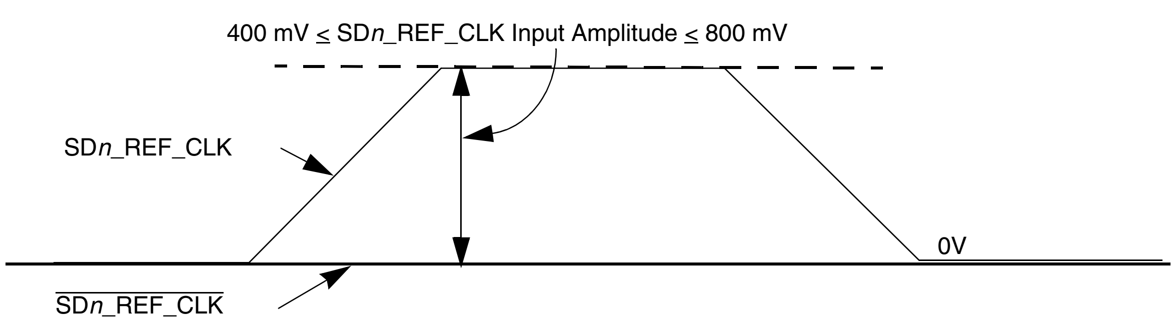


Figure 42. Single-Ended Reference Clock Input DC Requirements

15.4 Equalization

With the use of high speed serial links, the interconnect media will cause degradation of the signal at the receiver. Effects such as Inter-Symbol Interference (ISI) or data dependent jitter are produced. This loss can be large enough to degrade the eye opening at the receiver beyond what is allowed in the specification. To negate a portion of these effects, equalization can be used. The most common equalization techniques that can be used are:

- A passive high pass filter network placed at the receiver. This is often referred to as passive equalization.
- The use of active circuits in the receiver. This is often referred to as adaptive equalization.

15.5 Explanatory Note on Transmitter and Receiver Specifications

AC electrical specifications are given for transmitter and receiver. Long run and short run interfaces at three baud rates (a total of six cases) are described.

The parameters for the AC electrical specifications are guided by the XAUI electrical interface specified in Clause 47 of IEEE 802.3ae-2002.

XAUI has similar application goals to serial RapidIO, as described in Section 8.1. The goal of this standard is that electrical designs for serial RapidIO can reuse electrical designs for XAUI, suitably modified for applications at the baud intervals and reaches described herein.

15.6 Transmitter Specifications

LP-Serial transmitter electrical and timing specifications are stated in the text and tables of this section.

The differential return loss, S11, of the transmitter in each case shall be better than

- –10 dB for (Baud Frequency)/10 < Freq(f) < 625 MHz, and
- –10 dB + 10log(f/625 MHz) dB for 625 MHz ≤ Freq(f) ≤ Baud Frequency

The reference impedance for the differential return loss measurements is 100 Ohm resistive. Differential return loss includes contributions from on-chip circuitry, chip packaging and any off-chip components related to the driver. The output impedance requirement applies to all valid output levels.

It is recommended that the 20%–80% rise/fall time of the transmitter, as measured at the transmitter output, in each case have a minimum value 60 ps.

It is recommended that the timing skew at the output of an LP-Serial transmitter between the two signals that comprise a differential pair not exceed 25 ps at 1.25 GB, 20 ps at 2.50 GB and 15 ps at 3.125 GB.

Table 52. Short Run Transmitter AC Timing Specifications—1.25 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output Voltage,	V_O	–0.40	2.30	Volts	Voltage relative to COMMON of either signal comprising a differential pair
Differential Output Voltage	V_{DIFFPP}	500	1000	mV p-p	—
Deterministic Jitter	J_D	—	0.17	UI p-p	—
Total Jitter	J_T	—	0.35	UI p-p	—
Multiple output skew	S_{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit Interval	UI	800	800	ps	+/– 100 ppm

Table 53. Short Run Transmitter AC Timing Specifications—2.5 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output Voltage,	V_O	–0.40	2.30	Volts	Voltage relative to COMMON of either signal comprising a differential pair
Differential Output Voltage	V_{DIFFPP}	500	1000	mV p-p	—
Deterministic Jitter	J_D	—	0.17	UI p-p	—
Total Jitter	J_T	—	0.35	UI p-p	—
Multiple Output skew	S_{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit Interval	UI	400	400	ps	+/– 100 ppm

Table 54. Short Run Transmitter AC Timing Specifications—3.125 GBaud

Characteristic	Symbol	Range		Unit	Notes
		Min	Max		
Output Voltage,	V_O	–0.40	2.30	Volts	Voltage relative to COMMON of either signal comprising a differential pair
Differential Output Voltage	V_{DIFFPP}	500	1000	mV p-p	—
Deterministic Jitter	J_D	—	0.17	UI p-p	—
Total Jitter	J_T	—	0.35	UI p-p	—

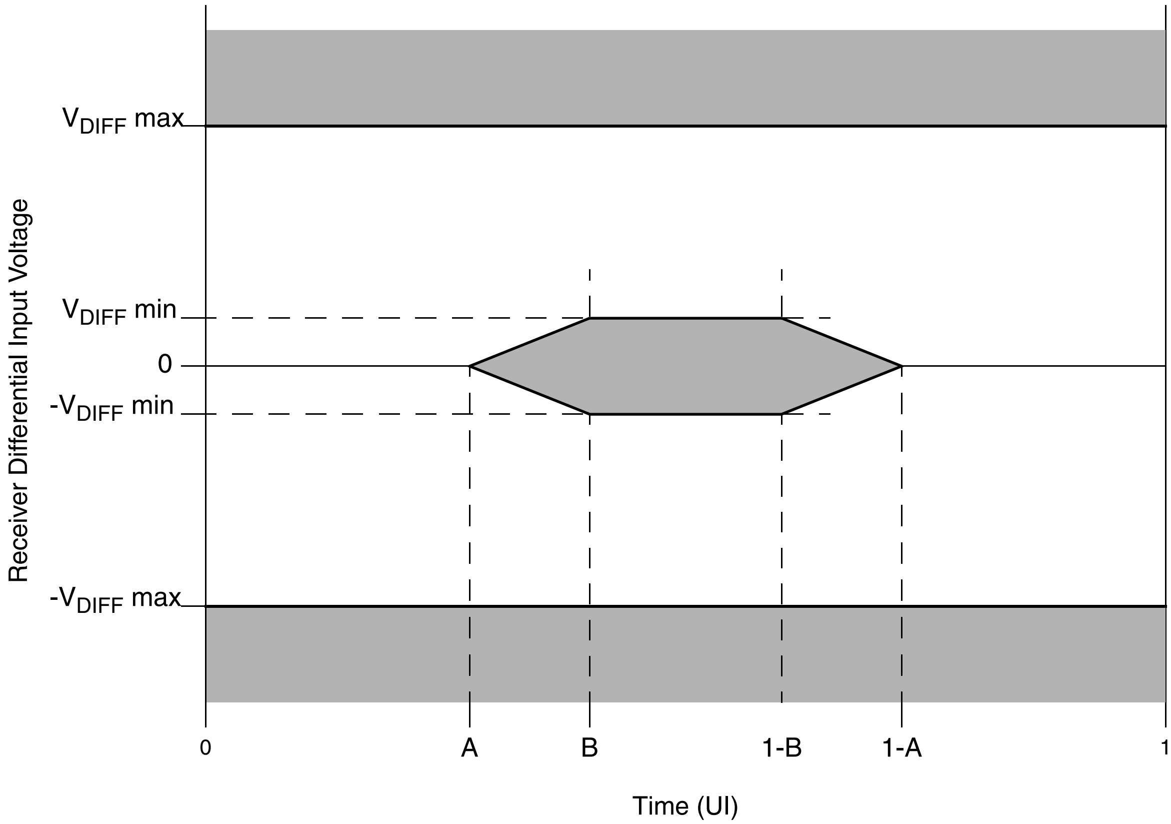


Figure 56. Receiver Input Compliance Mask

Table 62. Receiver Input Compliance Mask Parameters Exclusive of Sinusoidal Jitter

Receiver Type	V_{DIFF}min (mV)	V_{DIFF}max (mV)	A (UI)	B (UI)
1.25 GBaud	100	800	0.275	0.400
2.5 GBaud	100	800	0.275	0.400
3.125 GBaud	100	800	0.275	0.400

15.9 Measurement and Test Requirements

Since the LP-Serial electrical specification are guided by the XAUI electrical interface specified in Clause 47 of IEEE 802.3ae-2002, the measurement and test requirements defined here are similarly guided by Clause 47. In addition, the CJPAT test pattern defined in Annex 48A of IEEE 802.3ae-2002 is specified as the test pattern for use in eye pattern and jitter measurements. Annex 48B of IEEE 802.3ae-2002 is recommended as a reference for additional information on jitter test methods.

15.9.1 Eye Template Measurements

For the purpose of eye template measurements, the effects of a single-pole high pass filter with a 3 dB point at (Baud Frequency)/1667 is applied to the jitter. The data pattern for template measurements is the

Table 63. MPC8641 Signal Reference by Functional Block (continued)

Name[1]	Package Pin Number	Pin Type	Power Supply	Notes
SD1_PLL_TPA	T28	Analog	SV_{DD}	13, 18
SD1_DLL_TPD	N28	O	SV_{DD}	13, 17
SD1_DLL_TPA	P31	Analog	SV_{DD}	13, 18
High Speed I/O Interface 2 (SERDES 2)[4]				
SD2_TX[0:3]	Y24, AA27, AB25, AC27	O	SV_{DD}	—
SD2_TX[4:7]	AE27, AG27, AJ27, AL27	O	SV_{DD}	34
$\overline{\text{SD2\_TX}}$[0:3]	Y25, AA28, AB26, AC28	O	SV_{DD}	—
$\overline{\text{SD2\_TX}}$[4:7]	AE28, AG28, AJ28, AL28	O	SV_{DD}	34
SD2_RX[0:3]	Y30, AA32, AB30, AC32	I	SV_{DD}	32
SD2_RX[4:7]	AH30, AJ32, AK30, AL32	I	SV_{DD}	32, 35
$\overline{\text{SD2\_RX}}$[0:3]	Y29, AA31, AB29, AC31	I	SV_{DD}	—
$\overline{\text{SD2\_RX}}$[4:7]	AH29, AJ31, AK29, AL31	I	SV_{DD}	35
SD2_REF_CLK	AE32	I	SV_{DD}	—
$\overline{\text{SD2\_REF\_CLK}}$	AE31	I	SV_{DD}	—
SD2_IMP_CAL_TX	AM29	Analog	SV_{DD}	19
SD2_IMP_CAL_RX	AA26	Analog	SV_{DD}	30
SD2_PLL_TPD	AF29	O	SV_{DD}	13, 17
SD2_PLL_TPA	AF31	Analog	SV_{DD}	13, 18
SD2_DLL_TPD	AD29	O	SV_{DD}	13, 17
SD2_DLL_TPA	AD30	Analog	SV_{DD}	13, 18
Special Connection Requirement pins				
No Connects	K24, K25, P28, P29, W26, W27, AD25, AD26	—	—	13
Reserved	H30, R32, V28, AG32	—	—	14
Reserved	H29, R31, W28, AG31	—	—	15
Reserved	AD24, AG26	—	—	16
Ethernet Miscellaneous Signals[5]				
EC1_GTX_CLK125	AL23	I	LV_{DD}	39
EC2_GTX_CLK125	AM23	I	TV_{DD}	39
EC_MDC	G31	O	OV_{DD}	—
EC_MDIO	G32	I/O	OV_{DD}	—
eTSEC Port 1 Signals[5]				

Table 63. MPC8641 Signal Reference by Functional Block (continued)

Name[1]	Package Pin Number	Pin Type	Power Supply	Notes
XV_{DD}_SRDS2	AA25, AB28, AC26, AD27, AE25, AF28, AH27, AK28, AM27, W24, Y27	Serial I/O Power Supply for SerDes Port 2	XV_{DD}_SRDS2 1.05/1.1 V	—
V_{DD}_Core0	L12, L13, L14, M13, M15, N12, N14, P11, P13, P15, R12, R14, T11, T13, T15, U12, U14, V11, V13, V15, W12, W14, Y12, Y13, Y15, AA12, AA14, AB13	Core 0 voltage supply	V_{DD}_Core0 0.95/1.05/1.1 V	—
V_{DD}_Core1	R16, R18, R20, T17, T19, T21, T23, U16, U18, U22, V17, V19, V21, V23, W16, W18, W20, W22, Y17, Y19, Y21, Y23, AA16, AA18, AA20, AA22, AB23, AC24	Core 1 voltage supply	V_{DD}_Core1 0.95/1.05/1.1 V	12, *S1*
V_{DD}_PLAT	M16, M17, M18, N16, N20, N22, P17, P19, P21, P23, R22	Platform supply voltage	V_{DD}_PLAT 1.05/1.1 V	—
AV_{DD}_Core0	B20	Core 0 PLL Supply	AV_{DD}_Core0 0.95/1.05/1.1 V	—
AV_{DD}_Core1	A19	Core 1 PLL Supply	AV_{DD}_Core1 0.95/1.05/1.1 V	12, *S2*
AV_{DD}_PLAT	B19	Platform PLL supply voltage	AV_{DD}_PLAT 1.05/1.1 V	—
AV_{DD}_LB	A20	Local Bus PLL supply voltage	AV_{DD}_LB 1.05/1.1 V	—
AV_{DD}_SRDS1	P32	SerDes Port 1 PLL & DLL Power Supply	AV_{DD}_SRDS1 1.05/1.1 V	—
AV_{DD}_SRDS2	AF32	SerDes Port 2 PLL & DLL Power Supply	AV_{DD}_SRDS2 1.05/1.1 V	—
GND	C3, C6, C9, C12, C15, C23, C26, E5, E8, E11, E14, E18, E25, E28, F3, G7, G10, G13, G20, G23, G27, G30, H5, J3, J9, J12, J15, J22, J25, K7, L5, L20, M3, M9, M12, N7, N11, N13, N15, N17, N19, N21, N23, P5, P12, P16, P20, P22, R3, R9, R11, R13, R15, R17, R19, R21, R23, T7, T12, T14, T16, T18, T20, T22, U5, U11,U13, U15, U17, U19, U21, U23, V3, V9, V12, V14, V16, V18, V22, W7, W11, W13, W15, W17, W19, W21, W23,Y5, Y14, Y16, Y18, Y20, Y22, AA3, AA9, AA13, AA15, AA17, AA19, AA21, AA23, AB7, AB24, AC5, AC11, AD3, AD9, AD15, AE7, AE13, AE18, AF5, AF11, AF21, AF24, AG3, AG9, AH7, AH13, AJ5, AJ11, AK3, AK9, AK15, AK19, AK23, AL7, AL13	GND	—	—

Tyco Electronics 800-522-6752
Chip Coolers™
P.O. Box 3668
Harrisburg, PA 17105-3668
Internet: www.chipcoolers.com

Wakefield Engineering 603-635-5102
33 Bridge St.
Pelham, NH 03076
Internet: www.wakefield.com

Ultimately, the final selection of an appropriate heat sink depends on many factors, such as thermal performance at a given air velocity, spatial volume, mass, attachment method, assembly, and cost.

19.2.1 Internal Package Conduction Resistance

For the exposed-die packaging technology described in Table 71, the intrinsic conduction thermal resistance paths are as follows:

- The die junction-to-case thermal resistance (the case is actually the top of the exposed silicon die)
- The die junction-to-board thermal resistance

Figure 60 depicts the primary heat transfer path for a package with an attached heat sink mounted to a printed-circuit board.

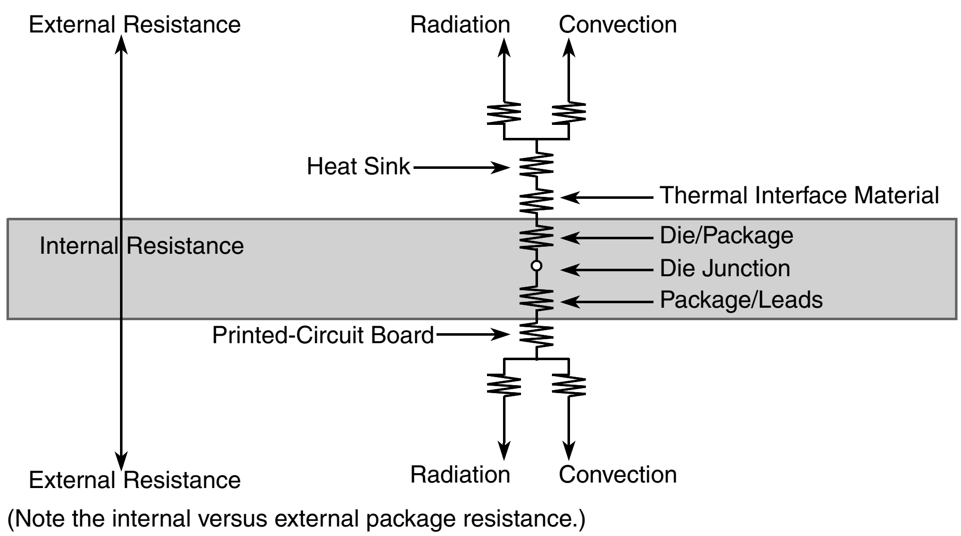


Figure 60. C4 Package with Heat Sink Mounted to a Printed-Circuit Board

Heat generated on the active side of the chip is conducted through the silicon, through the heat sink attach material (or thermal interface material), and finally to the heat sink where it is removed by forced-air convection.

Because the silicon thermal resistance is quite small, the temperature drop in the silicon may be neglected for a first-order analysis. Thus the thermal interface material and the heat sink conduction/convective thermal resistances are the dominant terms.

19.2.2 Thermal Interface Materials

A thermal interface material is recommended at the package-to-heat sink interface to minimize the thermal contact resistance. Figure 61 shows the thermal performance of three thin-sheet thermal-interface materials (silicone, graphite/oil, floroether oil), a bare joint, and a joint with thermal grease as a function of contact pressure. As shown, the performance of these thermal interface materials improves with increasing contact pressure. The use of thermal grease significantly reduces the interface thermal resistance. That is, the bare joint results in a thermal resistance approximately seven times greater than the thermal grease joint.

Often, heat sinks are attached to the package by means of a spring clip to holes in the printed-circuit board (see Figure 59). Therefore, synthetic grease offers the best thermal performance, considering the low interface pressure, and is recommended due to the high power dissipation of the MPC8641. Of course, the selection of any thermal interface material depends on many factors—thermal performance requirements, manufacturability, service temperature, dielectric properties, cost, and so on.

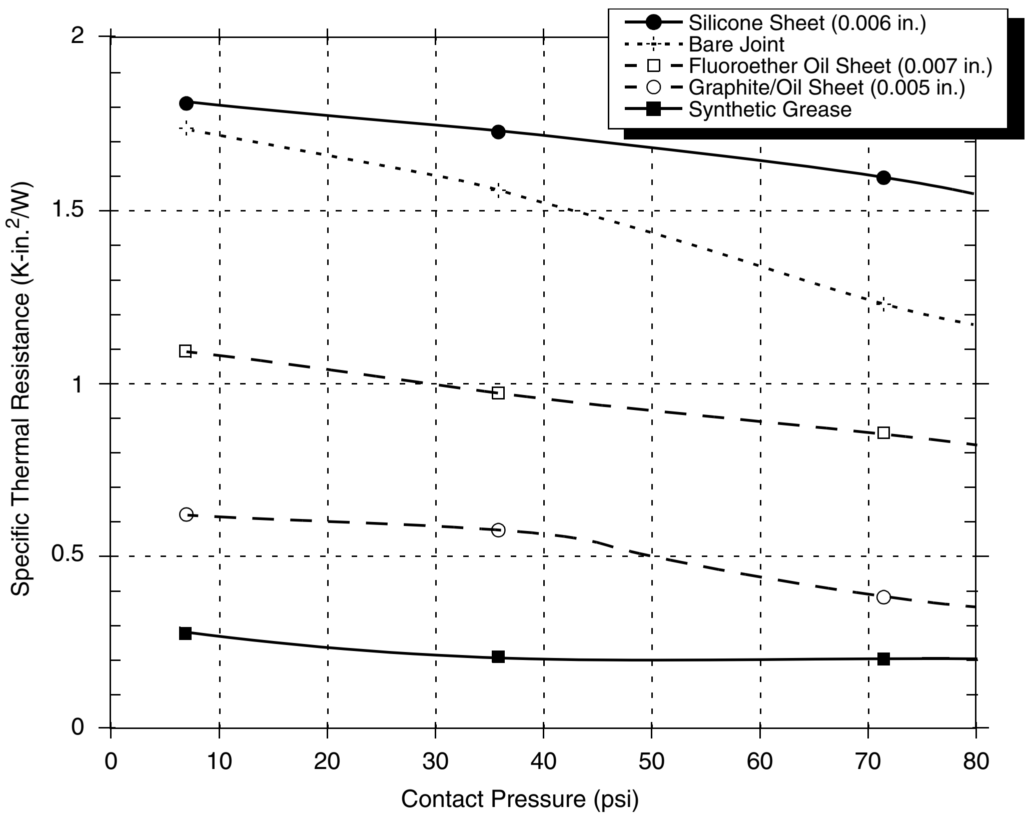


Figure 61. Thermal Performance of Select Thermal Interface Material

The board designer can choose between several types of thermal interface. Heat sink adhesive materials should be selected based on high conductivity and mechanical strength to meet equipment shock/vibration requirements. There are several commercially available thermal interfaces and adhesive materials provided by the following vendors:

Conductivity	Value	Unit
Die (12.4x15.3x0.86 mm)		
Silicon	Temperature dependent	
Bump and Underfill (12.4 × 15.3 × 0.07 mm) Collapsed Resistance		
k_z	5.3	W/(m • K)
Substrate (33 × 33 × 1.2 mm)		
k_x	13.5	W/(m • K)
k_y	13.5	
k_z	5.3	
C5 Solder layer (33 × 33 × 0.4 mm)		
k_x	0.034	W/(m • K)
k_y	0.034	
k_z	9.6	

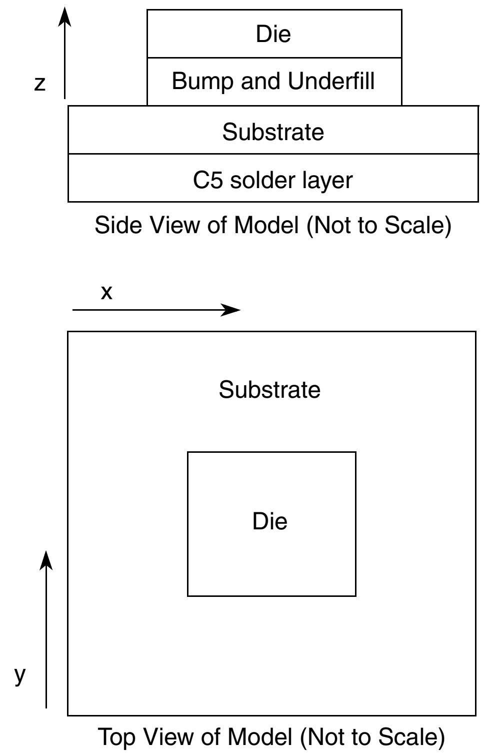


Figure 62. Recommended Thermal Model of MPC8641

19.2.4 Temperature Diode

The MPC8641 has a temperature diode on the microprocessor that can be used in conjunction with other system temperature monitoring devices (such as Analog Devices, ADT7461™). These devices use the negative temperature coefficient of a diode operated at a constant current to determine the temperature of the microprocessor and its environment. It is recommended that each device be individually calibrated.

The following are the specifications of the MPC8641 on-board temperature diode:

$V_f > 0.40$ V

$V_f < 0.90$ V

An approximate value of the ideality may be obtained by calibrating the device near the expected operating temperature.

Ideality factor is defined as the deviation from the ideal diode equation:

$$I_{fw} = I_s \left[e^{\frac{qV_f}{nKT}} - 1 \right]$$

Table 75 shows the parts that are available for ordering and their operating conditions.

Table 75. Part Offerings and Operating Conditions

Part Offerings[1]	Operating Conditions
MC8641Dxx1500KX	Dual core Max CPU speed = 1500 MHz, Max DDR = 600 MHz Core Voltage = 1.1 volts
MC8641Dxx1333JX	Dual core Max CPU speed = 1333 MHz, Max DDR = 533 MHz Core Voltage = 1.05 volts
MC8641Dxx1250HX	Dual core Max CPU speed = 1250 MHz, Max DDR = 500 MHz Core Voltage = 1.05 volts
MC8641Dxx1000GX	Dual core Max CPU speed = 1000 MHz, Max DDR = 400 MHz Core Voltage = 1.05 volts
MC8641Dxx1000NX	Dual core MAX CPU speed = 1000 MHz, MAX DDR = 500 MHz Core Voltage = 0.95 volts
MC8641xx1500KX	Single core Max CPU speed = 1500 MHz, Max DDR = 600 MHz Core Voltage = 1.1 volts
MC8641xx1333JX	Single core Max CPU speed = 1333 MHz, Max DDR = 533 MHz Core Voltage = 1.05 volts
MC8641xx1250HX	Single core Max CPU speed = 1250 MHz, Max DDR = 500 MHz Core Voltage = 1.05 volts
MC8641xx1000HX	Single core Max CPU speed = 1000 MHz, Max DDR = 400 MHz Core Voltage = 1.05 volts
MC8641xx1000NX	Single core Max CPU speed = 1000 MHz, Max DDR = 500 MHz Core Voltage = 0.95 volts

[1] Note that the “xx” in the part marking represents the package option. The upper case “X” represents the revision letter. For more information see Table 74.

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